


<b>Search Notes</b>  	<b>Application/Control No.</b>  10775668	<b>Applicant(s)/Patent Under Reexamination</b>  MACK ET AL.
	<b>Examiner</b>  Tayong, Helene	<b>Art Unit</b>  <del>2609</del> 2611

SEARCHED			
Class	Subclass	Date	Examiner
375	130, 140, 141, 146, 142, 147, 150, 505	1/30/07	HT
332	112	11/14/07	HT
370	213	11/14/07	HT

SEARCH NOTES		
Search Notes	Date	Examiner
US_PGPUB, USPAT, USOCR, FPRS, EPO, JPO, DERWENT, IBM-TDB	1/29/07	Helene Tayong
GOOGLE	1/29/07	Helene Tayong
EAST	1/29/07	Helene Tayong
IEEE EXPLORER	1/29/07	Helene Tayong
Consult with Search Assistant in 2609	1/29/07	Helene Tayong
EAST	5/30/07	Helene tayong
Consulted with SPE (David Payne)	5/30/07	Helene tayong
Consulted with SPE (Shuwang Liu)	11/15/07	HT
NPL	11/15/07	HT
Inventor Name search	1/28/08	HT

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
same as above		11/15/07	HT
Same as above		1/28/08	HT